Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/523,937	LATRILLE ET AL.	
Examiner	Art Unit	
Taeyoon Kim	1651	

	SEARCHED					
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST search (USPG- pub;USPAT;USOCR;EPO;JPO;Derwe nt)	10/16/2006	тк		
PubMed (destabilase, leech)	10/16/2006	тк		
Inventor search (PALM)	10/20/2006	TK		
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